

Notice of References Cited		Application/Control No. 10/531,707	Applicant(s)/Patent Under Reexamination TAKEZAWA ET AL.	
		Examiner BRIAN P. YENKE	Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,972,808	12-2005	Hong et al.	348/749
*	B	US-6,871,962	03-2005	Kane, Jeffrey Scott	353/100
*	C	US-6,456,341	09-2002	Jung, Sung-su	348/776
*	D	US-6,384,874	05-2002	Ushizaka, Yuuichi	348/749
*	E	US-6,093,998	07-2000	Takezawa, Hiroyuki	313/36
*	F	US-2005/0133421	06-2005	Peet et al.	210/168
*	G	US-6,273,021	08-2001	Pembroke, Kevin	116/228
*	H	US-6,253,399	07-2001	Wagner, William J.	5/507.1
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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